

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination CLARK ET AL.	
		Examiner Chuck Huynh	Art Unit 2683	Page 1 of 1

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*	C	US-6,757,729	06-2004	Devarakonda et al.	709/226
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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